

BBS3002-VB Datasheet

P-Channel 60 V (D-S) 175 °C MOSFET

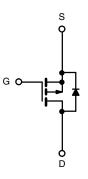
PRODUCT SUMMARY					
V _{DS} (V)	_{DS} (V) R _{DS(on)} (Ω)				
-60	0.0050 at V _{GS} = -10 V	-120			
	0.0070 at V_{GS} = -4.5 V	-120			



FEATURES

- Trench power MOSFET
- Package with low thermal resistance





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	V _{DS}	-60	V			
Gate-Source Voltage	V _{GS}	± 20	v			
Continuous Drain Current ^d	T _C = 25 °C		-120			
(T _J = 175 °C)	T _C = 125 °C		-95			
Pulsed Drain Current	I _{DM}	-350	A			
Avalanche Current	L = 0.1 mH	I _{AS}	-75			
Single Pulse Avalanche Energy ^a	L = 0.1 MH	E _{AS}	281	mJ		
Dower Dissingtion	T _C = 25 °C °	D	375	w		
Power Dissipation	T _A = 25 °C ^b	P _D —	3.75			
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	UNIT		
Junction-to-Ambient	PCB mount ^b	R _{thJA}	40	°C/W		
Junction-to-Case		R _{thJC}	0.4	0/11		

Notes

- a. Duty cycle \leq 1 %.
- b. When mounted on 1" square PCB (FR4 material).
- c. See SOA curve for voltage derating.
- d. Limited by package.

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static						[
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = -250 \mu A$	-60	-	-	v	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-1	-	-3		
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$	-	-	± 100	nA	
		$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	-1	μA	
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} = -60 V, V_{GS} = 0 V, T_{J} = 125 °C	-	-	-50		
		V_{DS} = -60 V, V_{GS} = 0 V, T_{J} = 175 °C	-	-	-250		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = -5 V, V_{GS} = -10 V$	-120	-	-	Α	
		$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -30 \text{ A}$	-	0.0050	-		
Drain-Source On-State Resistance ^a	Б	V_{GS} = -10 V, I_D = -30 A, T_J = 125 °C	-	0.0115	-	Ω	
Drain-Source On-State Resistance	R _{DS(on)}	V_{GS} = -10 V, I_D = -30 A, T_J = 175 °C	-	0.0138	-		
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -20 \text{ A}$	-	0.0070	-		
Forward Transconductance ^a	9 _{fs}	V _{DS} = -15 V, I _D = -50 A	20	-	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	11 400	-	pF	
Output Capacitance	Coss	$V_{GS} = 0 V$, $V_{DS} = -25 V$, f = 1 MHz	-	1200	-		
Reverse Transfer Capacitance	C _{rss}		-	900	-		
Total Gate Charge ^c	Qg		-	230	345	nC	
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -110 \text{ A}$	-	50	-		
Gate-Drain Charge ^c	Q _{gd}		-	60	-		
Gate Resistance	R _g	f = 1 MHz	-	3	-	Ω	
Turn-On Delay Time ^c	t _{d(on)}		-	20	30		
Rise Time ^c	t _r	$V_{DD} = -30 \text{ V}, \text{ R}_{\text{I}} = 0.27 \Omega$	-	25	40	ns	
Turn-Off Delay Time ^c	t _{d(off)}	$I_D\cong -110~\text{A},~V_{\text{GEN}}=-10~\text{V},~\text{R}_{\text{g}}=1~\Omega$	-	110	200		
Fall Time ^c	t _f		-	50	100		
Drain-Source Body Diode Character	istics (T _C = 25	o °C ♭)					
Continuous Current	I _S		-	-	-110	^	
Pulsed Current	I _{SM}		-	-	-240	A	
Forward Voltage ^a	V _{SD}	I _F = -85 A, V _{GS} = 0 V	-	-1	-1.5	V	
Reverse Recovery Time	t _{rr}		-	91	137	ns	
Peak Reverse Recovery Charge	I _{RM(REC)}	I _F = -85 A, dl/dt = 100 A/µs	-	-6	-9	А	
Reverse Recovery Charge	Q _{rr}		-	0.21	0.44	μC	

Notes

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



T_C = 125 °C

3

-55 °C

4

 $V_{GS} = 10 V$

100

120

80

5

25 °C

2

V_{GS} = 4.5 V

60

I_D - Drain Current (A)

40

150

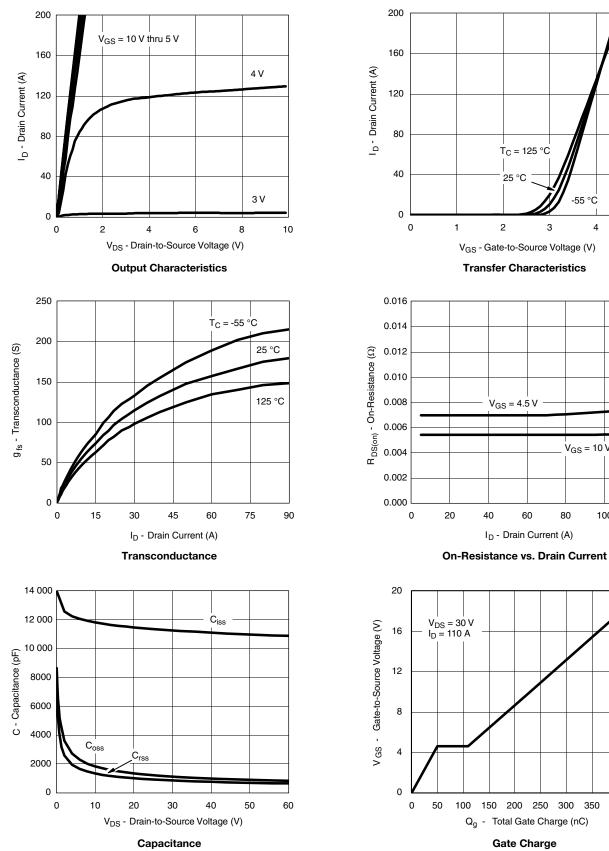
200 250 300

Total Gate Charge (nC)

Gate Charge

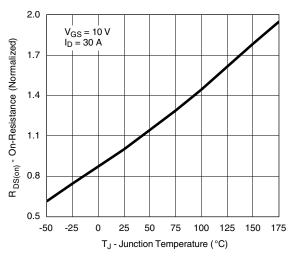
350

400 450

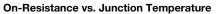


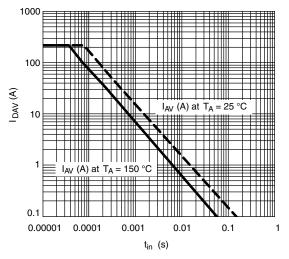
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



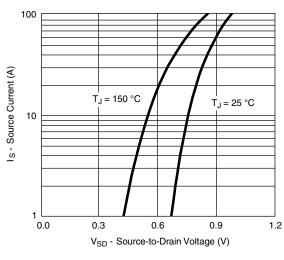


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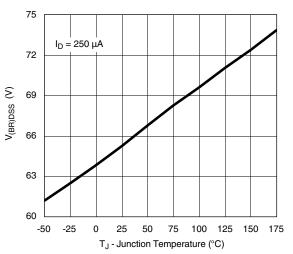




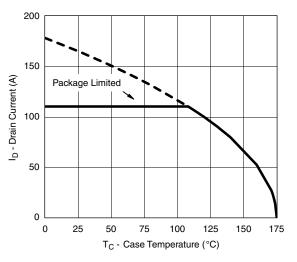




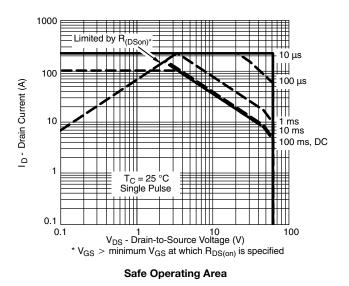
Source-Drain Diode Forward Voltage



Drain Source Breakdown vs. Junction Temperature

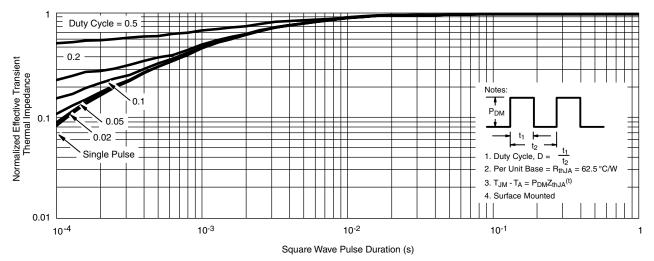


Maximum Avalanche and Drain Current vs. Case Temperature





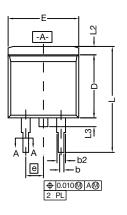
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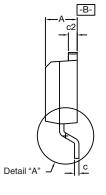


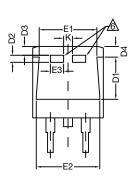
Normalized Thermal Transient Impedance, Junction-to-Case



TO-263 (D²PAK): 3-LEAD

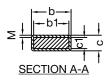








DETAIL A (ROTATED 90°)



		INC	HES	MILLIMETERS			
DIM.		MIN.	MAX.	MIN.	MAX.		
А		0.160	0.190	4.064	4.826		
b		0.020	0.039	0.508	0.990		
	b1	0.020	0.035	0.508	0.889		
	b2	0.045	0.055	1.143	1.397		
с*	Thin lead	0.013	0.018	0.330	0.457		
C	Thick lead	0.023	0.028	0.584	0.711		
c1	Thin lead	0.013	0.017	0.330	0.431		
CI	Thick lead	0.023	0.027	0.584	0.685		
c2		0.045	0.055	1.143	1.397		
	D	0.340	0.380	8.636	9.652		
D1		0.220	0.240	5.588	6.096		
D2		0.038	0.042	0.965	1.067		
D3		0.045	0.055	1.143	1.397		
D4		0.044	0.052	1.118	1.321		
	E	0.380	0.410	9.652	10.414		
	E1	0.245	-	6.223	-		
E2		0.355	0.375	9.017	9.525		
E3		0.072	0.078	1.829	1.981		
	е	0.100	BSC	2.54	BSC		
	К	0.045	0.055	1.143	1.397		
L		0.575	0.625	14.605	15.875		
L1		0.090	0.110	2.286	2.794		
L2		0.040	0.055	1.016	1.397		
L3		0.050	0.070	1.270	1.778		
	L4	0.010 BSC		0.254 BSC			
М		-	0.002	-	0.050		
ECN: T13-0707-Rev. K, 30-Sep-13 DWG: 5843							

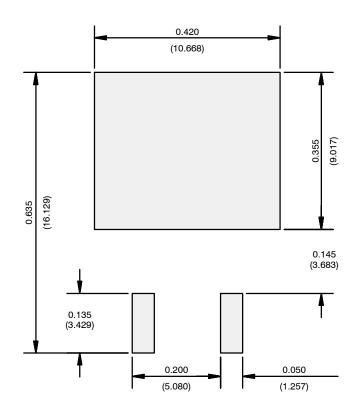
Notes

- 1. Plane B includes maximum features of heat sink tab and plastic. 2. No more than 25 % of L1 can fall above seating plane by
- max. 8 mils.3. Pin-to-pin coplanarity max. 4 mils.
- 4. *: Thin lead is for SUB, SYB.
 - Thick lead is for SUM, SYM, SQM.
- 5. Use inches as the primary measurement.

This feature is for thick lead.







Recommended Minimum Pads Dimensions in Inches/(mm)



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